

December 2011

FDS6911

Dual N-Channel Logic Level PowerTrench[®] MOSFET 20V, 7.5A, $13m\Omega$

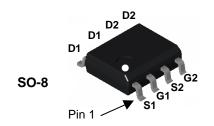
General Description

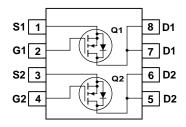
These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Features

- $\begin{array}{ll} \blacksquare & r_{DS(on)} = 13 \ m\Omega \ @ \ V_{GS} = 10 \ V \\ r_{DS(on)} = 17 \ m\Omega \ @ \ V_{GS} = 4.5 \ V \\ \end{array}$
- Fast switching speed
- Low gate charge
- High performance trench technology for extremely low R_{DS(ON)}
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|---|------------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 20 | V |
| V _{GSS} | Gate-Source Voltage | | ± 20 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 7.5 | Α |
| | - Pulsed | | 20 | |
| P _D | Power Dissipation for Single Operation | (Note 1a) | 1.6 | W |
| | | (Note 1b) | 1.0 | |
| | | (Note 1c) | 0.9 | |
| T _J , T _{STG} | Operating and Storage Junction Temperat | ture Range | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 78 | °C/W |
|------------------|---|-----------|----|------|
| R _{eJC} | Thermal Resistance, Junction-to-Case | (Note 1) | 40 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|---------|-----------|------------|------------|
| FDS6911 | FDS6911 | 13" | 12mm | 2500 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---|---|---|-----|--------------------|----------------|-------|
| Off Char | acteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$ | 20 | | | V |
| <u>ΔBV_{DSS}</u> ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu A$, Referenced to $25^{\circ}C$ | | 28 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55^{\circ}\text{C}$ | | | 1 10 | μА |
| I _{GSS} | Gate-Source Leakage | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ | 1 | 1.8 | 3 | V |
| $\Delta V_{GS(th)} \over \Delta T_J$ | Gate Threshold Voltage Temperature Coefficient | $I_D = 250 \mu A$, Referenced to $25^{\circ}C$ | | -4.7 | | mV/°C |
| r _{DS(on)} | Static Drain–Source On–Resistance | $V_{GS} = 10 \text{ V}, I_D = 7.5 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 6.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 7.5 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | 10.6 13 14.5 | 13 17 20 | mΩ |
| I _{D(on)} | On-State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ | 20 | | | Α |
| g FS | Forward Transconductance | $V_{DS} = 5 \text{ V}, \qquad I_{D} = 7.5 \text{ A}$ | | 36 | | S |
| Dynamic | Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ | | 1130 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 300 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 100 | | pF |
| R _G | Gate Resistance | V _{GS} = 15 mV, f = 1.0 MHz | | 2.4 | | Ω |
| Switchin | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 15 \text{ V}, I_{D} = 1 \text{ A},$ | | 9 | 18 | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | | 5 | 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 26 | 42 | ns |
| t _f | Turn-Off Fall Time | | | 7 | 14 | ns |
| Q _{g(TOT)} | Total Gate Charge at Vgs=10V | | | 17 | 24 | nC |
| Q _g | Total Gate Charge at Vgs=5V | $V_{DD} = 15 \text{ V}, I_D = 7.5 \text{ A},$ | | 9 | 13 | nC |
| Q_{gs} | Gate-Source Charge | | | 3.1 | | nC |
| Q_{gd} | Gate-Drain Charge | 7 | | 2.7 | | nC |

| Electrical Characteristics TA = 25℃ unless otherwise noted | | | | | | |
|--|---------------------------------------|---|-----|-----|-----|-------|
| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
| Drain-Sou | rce Diode Characteristics and | Maximum Ratings | | | | |
| Is | Maximum Continuous Drain-Source D | ontinuous Drain-Source Diode Forward Current 1.3 A | | | Α | |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A} \text{(Note 2)}$ | | | 1.2 | V |
| t _{rr} | Diode Reverse Recovery Time | $I_F = 7.5 \text{ A}, d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$ | | 24 | | nS |
| Q _{rr} | Diode Reverse Recovery Charge | | | 13 | | nC |

Notes

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a) 78°C/W when mounted on a 0.5 in² pad of 2 oz copper



b) 125℃/W when mounted on a .02 in² pad of 2 oz copper

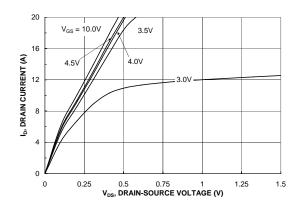


c) 135°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

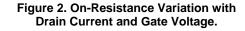
2. Pulse Test: Pulse Width < $300\mu s,$ Duty Cycle < 2.0%

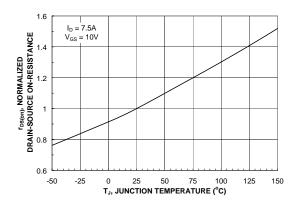
Typical Characteristics



2.6 V_{GS} = 3.0V V

Figure 1. On-Region Characteristics.





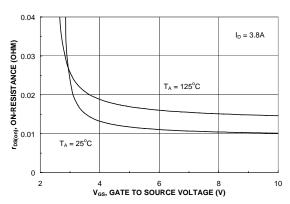
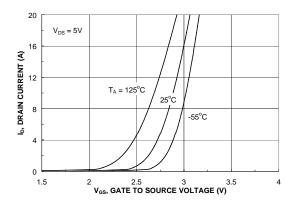


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



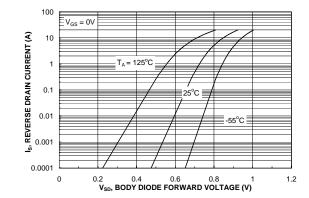
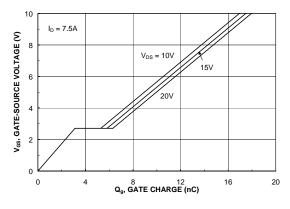


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



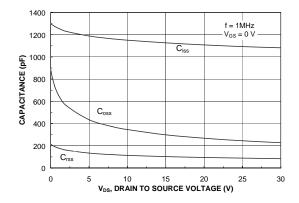
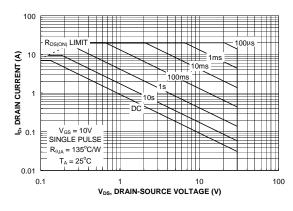


Figure 7. Gate Charge Characteristics.





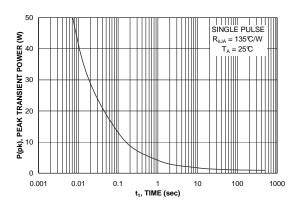


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

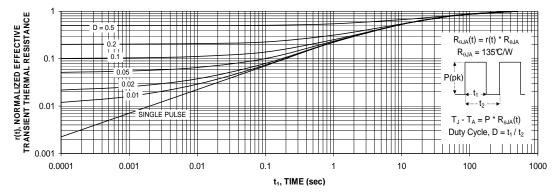


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.





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